



One Megabit per Second Triple Digital Isolators

FEATURES

- 1-Mbps Signaling Rate
 - Low Channel-to-Channel Output Skew; 1 ns max
 - Low Pulse-Width Distortion (PWD); 2 ns max
 - Low Jitter Content; 1 ns Typ at 150 Mbps
- Typical 25-Year Life at Rated Working Voltage (see application note [SLLA197](#) and [Figure 10](#))
- 4000-V_{peak} Isolation, 560-V_{peak} V_{IORM}
 - UL 1577, IEC 60747-5-2 (VDE 0884, Rev 2), IE 61010-1 and CSA Approved
- 4 kV ESD Protection
- Operate With 3.3-V or 5-V Supplies

- High Electromagnetic Immunity (see application note [SLLA181](#))
- –40°C to 125°C Operating Range

APPLICATIONS

- Industrial Fieldbus
- Computer Peripheral Interface
- Servo Control Interface
- Data Acquisition

DESCRIPTION

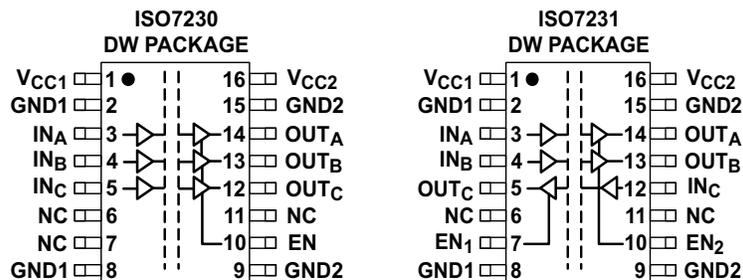
The ISO7230A and ISO7231A are triple-channel digital isolators each with multiple channel configurations and output enable functions. These devices have logic input and output buffers separated by TI's silicon dioxide (SiO₂) isolation barrier. Used in conjunction with isolated power supplies, these devices block high voltage, isolate grounds, and prevent noise currents on a data bus or other circuits from entering the local ground and interfering with or damaging sensitive circuitry.

The ISO7230 triple-channel device has all three channels in the same direction while the ISO7231 has two channels in one direction and one channel in opposition. These devices have an active-high output enable that when driven to a low level, places the output in a high-impedance state and turns off internal bias circuitry to conserve power.

The ISO7230A and ISO7231A have TTL input thresholds and a noise-filter at the input that prevents transient pulses of up to 2 ns in duration from being passed to the output of the device.

In each device a periodic update pulse is sent across the isolation barrier to ensure the proper dc level of the output. If this dc-refresh pulse is not received, the input is assumed to be unpowered or not being actively driven, and the failsafe circuit drives the output to a logic high state. (Contact TI for a logic low failsafe option).

These devices require two supply voltages of 3.3-V, 5-V, or any combination. All inputs are 5-V tolerant when supplied from a 3.3-V supply and all outputs are 4-mA CMOS. These devices are characterized for operation over the ambient temperature range of –40°C to 125°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

FUNCTION DIAGRAM

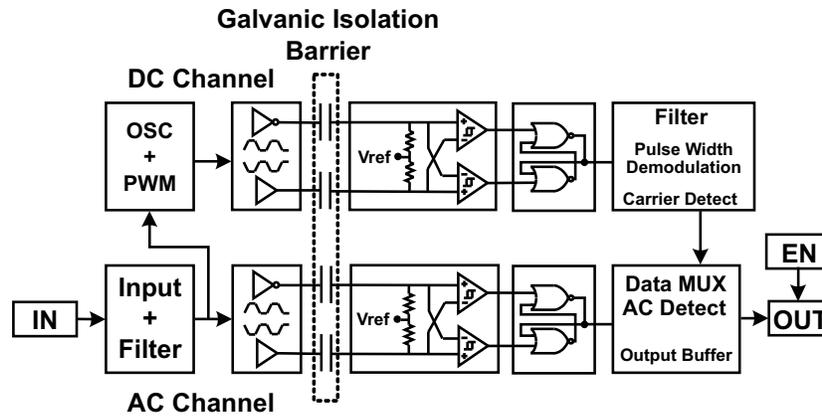


Table 1. Device Function Table ISO723x ⁽¹⁾

V _{CC1}	V _{CC2}	INPUT (IN)	OUTPUT ENABLE (EN)	OUTPUT (OUT)
PU	PU	H	H or Open	H
		L	H or Open	L
		X	L	Z
		Open	H or Open	H
PD	PU	X	H or Open	H
PD	PU	X	L	Z

(1) PU = Powered Up; PD = Powered Down ; X = Irrelevant; H = High Level; L = Low Level

AVAILABLE OPTIONS

PRODUCT	SIGNALING RATE	INPUT THRESHOLD	CHANNEL CONFIGURATION	MARKED AS	ORDERING NUMBER ⁽¹⁾
ISO7230ADW	1 Mbps	~1.5 V (TTL) (CMOS compatible)	3/0	ISO7230A	ISO7230ADW (rail)
					ISO7230ADWR (reel)
ISO7231ADW	1 Mbps	~1.5 V (TTL) (CMOS compatible)	2/1	ISO7231A	ISO7231ADW (rail)
					ISO7231ADWR (reel)

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

			VALUE	UNIT	
V_{CC}	Supply voltage ⁽²⁾ , V_{CC1} , V_{CC2}		–0.5 to 6	V	
V_I	Voltage at IN, OUT, EN		–0.5 to 6	V	
I_O	Output current		±15	mA	
ESD	Electrostatic discharge	Human Body Model	JEDEC Standard 22, Test Method A114-C.01	±4	kV
		Field-Induced-Charged Device Model	JEDEC Standard 22, Test Method C101		
		Machine Model	ANSI/ESDS5.2-1996	±1	
			±200	V	
T_J	Maximum junction temperature		170	°C	

- (1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values are with respect to network ground terminal and are peak voltage values.

RECOMMENDED OPERATING CONDITIONS

		MIN	TYP	MAX	UNIT
V_{CC}	Supply voltage ⁽¹⁾ , V_{CC1} , V_{CC2}	3.15		5.5	V
I_{OH}	High-level output current			4	mA
I_{OL}	Low-level output current	–4			mA
t_{ui}	Input pulse width	1			µs
$1/t_{ui}$	Signaling rate	0	1500 ⁽²⁾	1000	kbps
V_{IH}	High-level input voltage (IN) (EN on all devices)	2		V_{CC}	V
V_{IL}	Low-level input voltage (IN) (EN on all devices)	0		0.8	
T_J	Junction temperature			150	°C
H	External magnetic field-strength immunity per IEC 61000-4-8 and IEC 61000-4-9 certification			1000	A/m

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.
- (2) Typical signalling rate under ideal conditions at 25°C.

ELECTRICAL CHARACTERISTICS: V_{CC1} and V_{CC2} at 5-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
SUPPLY CURRENT							
I_{CC1}	ISO7230A	Quiescent	$V_1 = V_{CC}$ or 0 V, All channels, no load, EN_2 at 3 V		1	3	mA
		1 Mbps			1	3	
	ISO7231A	Quiescent	$V_1 = V_{CC}$ or 0 V, All channels, no load, EN_1 at 3 V, EN_2 at 3 V		6.5	11	mA
		1 Mbps			6.5	11	
I_{CC2}	ISO7230A	Quiescent	$V_1 = V_{CC}$ or 0 V, All channels, no load, EN_2 at 3 V		15	22	mA
		1 Mbps			16	22	
	ISO7231A	Quiescent	$V_1 = V_{CC}$ or 0 V, All channels, no load, EN_1 at 3 V, EN_2 at 3 V		13	20	mA
		1 Mbps			13	20	
ELECTRICAL CHARACTERISTICS							
I_{OFF}	Sleep mode output current	EN at V_{CC} , Single channel			0		μ A
V_{OH}	High-level output voltage	$I_{OH} = -4$ mA, See Figure 1		$V_{CC} - 0.8$			V
		$I_{OH} = -20$ μ A, See Figure 1		$V_{CC} - 0.1$			
V_{OL}	Low-level output voltage	$I_{OL} = 4$ mA, See Figure 1				0.4	V
		$I_{OL} = 20$ μ A, See Figure 1				0.1	
$V_{I(HYS)}$	Input voltage hysteresis			150			mV
I_{IH}	High-level input current	IN from 0 V to V_{CC}				10	μ A
I_{IL}	Low-level input current			-10			
C_1	Input capacitance to ground	IN at V_{CC} , $V_1 = 0.4 \sin(4E6\pi t)$		2			pF
CMTI	Common-mode transient immunity	$V_1 = V_{CC}$ or 0 V, See Figure 4		25	50		kV/ μ s

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} and V_{CC2} at 5-V OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay	See Figure 1		40		95	ns
PWD	Pulse-width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $						
$t_{sk(o)}$	Channel-to-channel output skew ⁽²⁾			0		2	ns
t_r	Output signal rise time	See Figure 1			2		ns
t_f	Output signal fall time					2	
t_{PHZ}	Propagation delay, high-level-to-high-impedance output	See Figure 2			15	20	ns
t_{PZH}	Propagation delay, high-impedance-to-high-level output				15	20	
t_{PLZ}	Propagation delay, low-level-to-high-impedance output				15	20	
t_{PZL}	Propagation delay, high-impedance-to-low-level output				15	20	
t_{fs}	Failsafe output delay time from input power loss	See Figure 3			12		μ s

- (1) Also referred to as pulse skew.
(2) $t_{sk(o)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

ELECTRICAL CHARACTERISTICS: V_{CC1} at 5-V, V_{CC2} at 3.3-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
SUPPLY CURRENT							
I_{CC1}	ISO7230A	Quiescent	$V_I = V_{CC}$ or 0 V, All channels, no load, EN ₂ at 3 V		1	3	mA
		1 Mbps			1	3	
	ISO7231A	Quiescent	$V_I = V_{CC}$ or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		6.5	11	mA
		1 Mbps			6.5	11	
I_{CC2}	ISO7230A	Quiescent	$V_I = V_{CC}$ or 0 V, All channels, no load, EN ₂ at 3 V		9	15	mA
		1 Mbps			9.5	15	
	ISO7231A	Quiescent	$V_I = V_{CC}$ or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		8	12	mA
		1 Mbps			8	12	
ELECTRICAL CHARACTERISTICS							
I_{OFF}	Sleep mode output current	EN at V _{CC} , Single channel			0		μA
V_{OH}	High-level output voltage	$I_{OH} = -4$ mA, See Figure 1	ISO7230	$V_{CC} - 0.4$			V
			ISO7231 (5-V side)	$V_{CC} - 0.8$			
		$I_{OH} = -20$ μA, See Figure 1		$V_{CC} - 0.1$			
V_{OL}	Low-level output voltage	$I_{OL} = 4$ mA, See Figure 1				0.4	V
		$I_{OL} = 20$ μA, See Figure 1				0.1	
$V_{I(HYS)}$	Input voltage hysteresis				150		mV
I_{IH}	High-level input current	IN from 0 V to V _{CC}				10	μA
I_{IL}	Low-level input current					-10	
C_I	Input capacitance to ground	IN at V _{CC} , $V_I = 0.4 \sin(4E6\pi t)$				2	pF
CMTI	Common-mode transient immunity	$V_I = V_{CC}$ or 0 V, See Figure 4			25	50	kV/μs

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
 For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} at 5-V, V_{CC2} at 3.3-V OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay, low-to-high-level output	ISO723xA See Figure 1	40		100	ns
PWD	Pulse-width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $					
$t_{sk(o)}$	Channel-to-channel output skew ⁽²⁾	ISO723xA/C		0	2.5	ns
t_r	Output signal rise time	See Figure 1		2		ns
t_f	Output signal fall time			2		
t_{PHZ}	Propagation delay, high-level-to-high-impedance output	See Figure 2		15	20	ns
t_{PZH}	Propagation delay, high-impedance-to-high-level output			15	20	
t_{PLZ}	Propagation delay, low-level-to-high-impedance output			15	20	
t_{PZL}	Propagation delay, high-impedance-to-low-level output			15	20	
t_{fs}	Failsafe output delay time from input power loss	See Figure 3		18		μs

- (1) Also known as pulse skew
 (2) $t_{sk(o)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

ELECTRICAL CHARACTERISTICS: V_{CC1} at 3.3-V, V_{CC2} at 5-V⁽¹⁾ OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
SUPPLY CURRENT							
I_{CC1}	ISO7230A	Quiescent	$V_I = V_{CC}$ or 0 V, All channels, no load, EN ₂ at 3 V		0.5	1	mA
		1 Mbps			1	2	
	ISO7231A	Quiescent	$V_I = V_{CC}$ or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		4.5	7	mA
		1 Mbps			4.5	7	
I_{CC2}	ISO7230A	Quiescent	$V_I = V_{CC}$ or 0 V, All channels, no load, EN ₂ at 3 V		15	22	mA
		1 Mbps			16	22	
	ISO7231A	Quiescent	$V_I = V_{CC}$ or 0 V, All channels, no load, EN ₁ at 3 V, EN ₂ at 3 V		13	20	mA
		1 Mbps			13	20	
ELECTRICAL CHARACTERISTICS							
I_{OFF}	Sleep mode output current	EN at V _{CC} , Single channel			0		μA
V_{OH}	High-level output voltage		$I_{OH} = -4$ mA, See Figure 1	ISO7230	$V_{CC} - 0.4$		V
				ISO7231 (5-V side)	$V_{CC} - 0.8$		
					$V_{CC} - 0.1$		
V_{OL}	Low-level output voltage		$I_{OL} = 4$ mA, See Figure 1		0.4		V
					0.1		
$V_{I(HYS)}$	Input voltage hysteresis				150		mV
I_{IH}	High-level input current	IN from 0 V to V _{CC}			10		μA
I_{IL}	Low-level input current				-10		
C_I	Input capacitance to ground	IN at V _{CC} , $V_I = 0.4 \sin(4E6\pi t)$			2		pF
CMTI	Common-mode transient immunity	$V_I = V_{CC}$ or 0 V, See Figure 4		25	50		kV/μs

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.

SWITCHING CHARACTERISTICS: V_{CC1} at 3.3-V and V_{CC2} at 5-V OPERATION

, over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{PLH}, t_{PHL}	Propagation delay	ISO723xA	See Figure 1	40		100	ns
PWD	Pulse-width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $				11		
$t_{sk(o)}$	Channel-to-channel output skew ⁽²⁾	ISO723xA			0	2.5	ns
t_r	Output signal rise time	See Figure 1			2		ns
t_f	Output signal fall time				2		
t_{PHZ}	Propagation delay, high-level-to-high-impedance output	See Figure 2			15	20	ns
t_{PZH}	Propagation delay, high-impedance-to-high-level output				15	20	
t_{PLZ}	Propagation delay, low-level-to-high-impedance output				15	20	
t_{PZL}	Propagation delay, high-impedance-to-low-level output				15	20	
t_{fs}	Failsafe output delay time from input power loss	See Figure 3			12		μs

- (1) Also known as pulse skew
(2) $t_{sk(o)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

ELECTRICAL CHARACTERISTICS: V_{CC1} and V_{CC2} at 3.3 V⁽¹⁾ OPERATION

, over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
SUPPLY CURRENT							
I_{CC1}	ISO7230A	Quiescent	$V_I = V_{CC}$ or 0 V, all channels, no load, EN_2 at 3 V	0.5		1	mA
		1 Mbps		1		2	
	ISO7231A	Quiescent	$V_I = V_{CC}$ or 0 V, all channels, no load, EN_1 at 3 V, EN_2 at 3 V	4.5		7	mA
		1 Mbps		4.5		7	
I_{CC2}	ISO7230A	Quiescent	$V_I = V_{CC}$ or 0 V, all channels, no load, EN_2 at 3 V	9		15	mA
		1 Mbps		9.5		15	
	ISO7231A	Quiescent	$V_I = V_{CC}$ or 0 V, all channels, no load, EN_1 at 3 V, EN_2 at 3 V	8		12	mA
		1 Mbps		8		12	
ELECTRICAL CHARACTERISTICS							
I_{OFF}	Sleep mode output current	EN at V_{CC} , single channel		0			μ A
V_{OH}	High-level output voltage	$I_{OH} = -4$ mA, See Figure 1		$V_{CC} - 0.4$			V
		$I_{OH} = -20$ μ A, See Figure 1		$V_{CC} - 0.1$			
V_{OL}	Low-level output voltage	$I_{OL} = 4$ mA, See Figure 1				0.4	V
		$I_{OL} = 20$ μ A, See Figure 1				0.1	
$V_{I(HYS)}$	Input voltage hysteresis			150			mV
I_{IH}	High-level input current	IN from 0 V or V_{CC}				10	μ A
I_{IL}	Low-level input current			-10			
C_I	Input capacitance to ground	IN at V_{CC} , $V_I = 0.4 \sin(4E6\pi t)$		2			pF
CMTI	Common-mode transient immunity	$V_I = V_{CC}$ or 0 V, See Figure 4		25	50		kV/ μ s

- (1) For the 5-V operation, V_{CC1} or V_{CC2} is specified from 4.5 V to 5.5 V.
For the 3-V operation, V_{CC1} or V_{CC2} is specified from 3.15 V to 3.6 V.

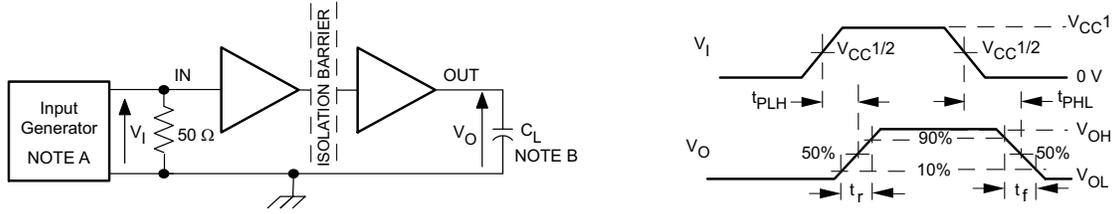
SWITCHING CHARACTERISTICS: V_{CC1} and V_{CC2} at 3.3-V OPERATION

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t_{PLH} , t_{PHL}	Propagation delay	ISO723xA	See Figure 1	45		110	ns
PWD	Pulse-width distortion ⁽¹⁾ $ t_{PHL} - t_{PLH} $						
$t_{sk(o)}$	Channel-to-channel output skew ⁽²⁾	ISO723xA		0		3	ns
t_r	Output signal rise time	See Figure 1			2		ns
t_f	Output signal fall time				2		
t_{PHZ}	Propagation delay, high-level-to-high-impedance output	See Figure 2			15	20	ns
t_{PZH}	Propagation delay, high-impedance-to-high-level output				15	20	
t_{PLZ}	Propagation delay, low-level-to-high-impedance output				15	20	
t_{PZL}	Propagation delay, high-impedance-to-low-level output				15	20	
t_{fs}	Failsafe output delay time from input power loss	See Figure 3		18			μ s

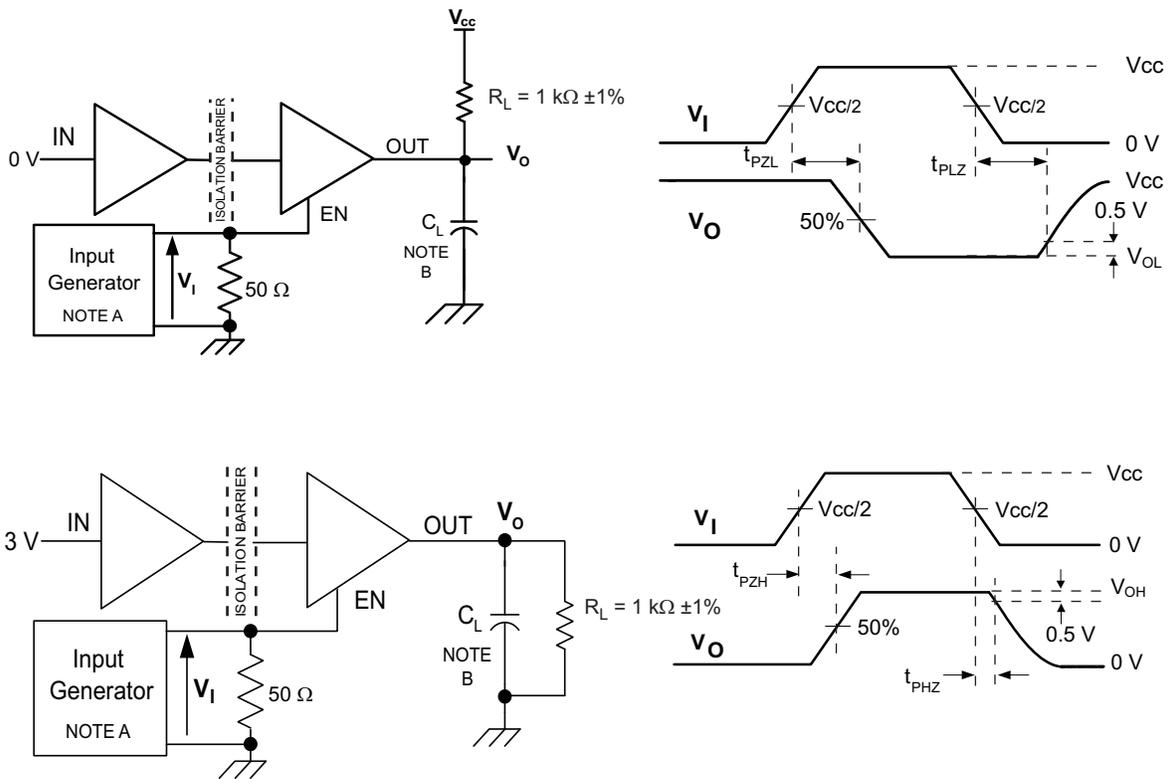
- (1) Also referred to as pulse skew.
(2) $t_{sk(o)}$ is the skew between specified outputs of a single device with all driving inputs connected together and the outputs switching in the same direction while driving identical specified loads.

PARAMETER MEASUREMENT INFORMATION



- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns, $Z_O = 50\ \Omega$.
- B. $C_L = 15\ \text{pF}$ and includes instrumentation and fixture capacitance within $\pm 20\%$.

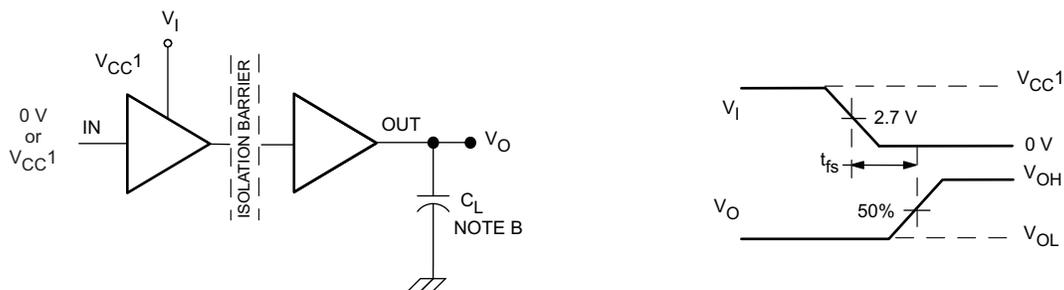
Figure 1. Switching Characteristic Test Circuit and Voltage Waveforms



- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns, $Z_O = 50\ \Omega$.
- B. $C_L = 15\ \text{pF}$ and includes instrumentation and fixture capacitance within $\pm 20\%$.

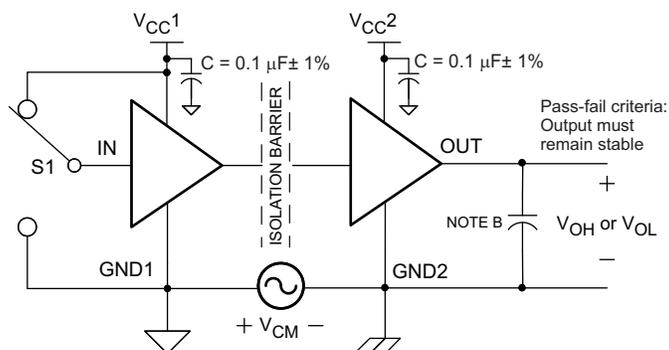
Figure 2. Enable/Disable Propagation Delay Time Test Circuit and Waveform

PARAMETER MEASUREMENT INFORMATION (continued)



- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns, $Z_O = 50\Omega$.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 3. Failsafe Delay Time Test Circuit and Voltage Waveforms



- A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 50 kHz, 50% duty cycle, $t_r \leq$ 3 ns, $t_f \leq$ 3 ns, $Z_O = 50\Omega$.
- B. $C_L = 15$ pF and includes instrumentation and fixture capacitance within $\pm 20\%$.

Figure 4. Common-Mode Transient Immunity Test Circuit and Voltage Waveform

DEVICE INFORMATION

PACKAGE CHARACTERISTICS

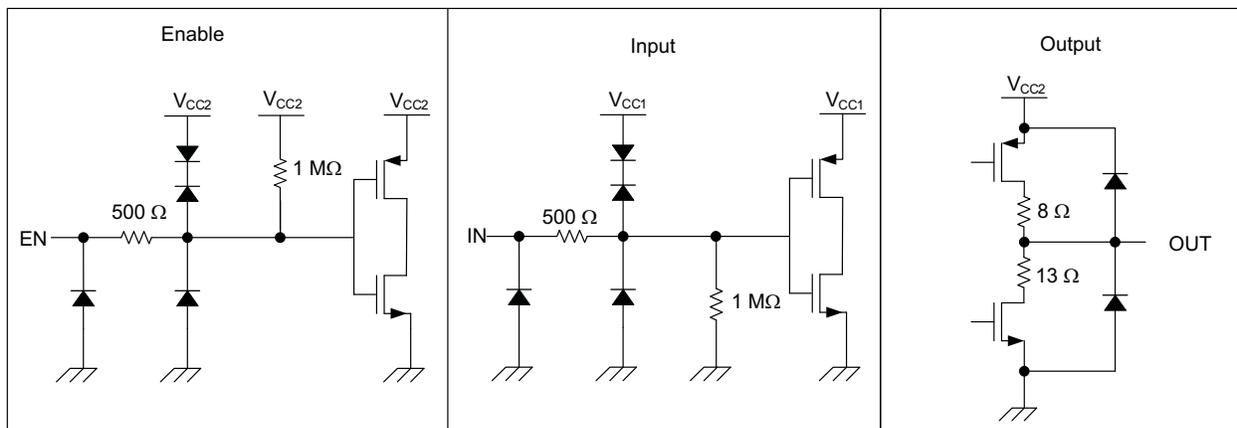
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
L(I01)	Minimum air gap (Clearance)	Shortest terminal-to-terminal distance through air	7.7			mm
L(I02)	Minimum external tracking (Creepage)	Shortest terminal-to-terminal distance across the package surface	8.1			mm
	Minimum Internal Gap (Internal Clearance)	Distance through the insulation	0.008			mm
R _{IO}	Isolation resistance	Input to output, V _{IO} = 500 V, all pins on each side of the barrier tied together creating a two-terminal device, T _A < 100°C		>10 ¹²		Ω
		Input to output, V _{IO} = 500 V, 100°C ≤ T _A ≤ T _A max		>10 ¹¹		Ω
C _{IO}	Barrier capacitance Input to output	V _I = 0.4 sin (4E6πt)		2		pF
C _I	Input capacitance to ground	V _I = 0.4 sin (4E6πt)		2		pF

REGULATORY INFORMATION

VDE	CSA	UL
Certified according to IEC 60747-5-2	Approved under CSA Component Acceptance Notice	Recognized under 1577 Component Recognition Program ⁽¹⁾
File Number: 40016131	File Number: 1698195	File Number: E181974

(1) Production tested ≥ 3000 VRMS for 1 second in accordance with UL 1577.

DEVICE I/O SCHEMATICS



THERMAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
θ_{JA}	Junction-to-air	Low-K Thermal Resistance ⁽¹⁾		168		°C/W
		High-K Thermal Resistance		96.1		
θ_{JB}	Junction-to-Board Thermal Resistance			61		°C/W
θ_{JC}	Junction-to-Case Thermal Resistance			48		°C/W
P_D	Device Power Dissipation	$V_{CC1} = V_{CC2} = 5.5\text{ V}$, $T_J = 150^\circ\text{C}$, $C_L = 15\text{ pF}$, Input a 50% duty cycle square wave			220	mW

(1) Tested in accordance with the Low-K or High-K thermal metric definitions of EIA/JESD51-3 for leaded surface mount packages.

TYPICAL CHARACTERISTIC CURVES

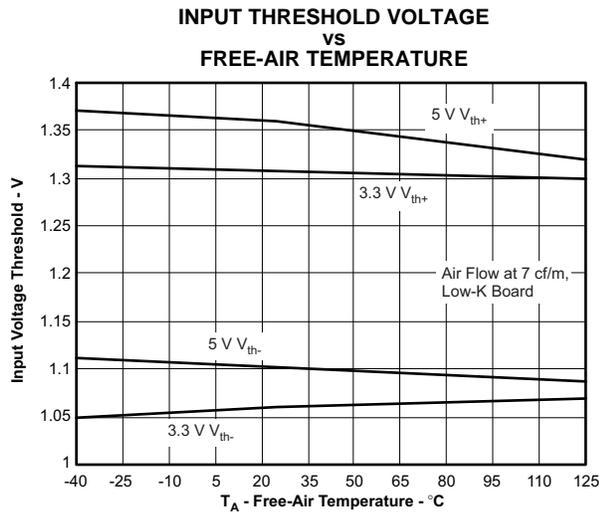


Figure 5.

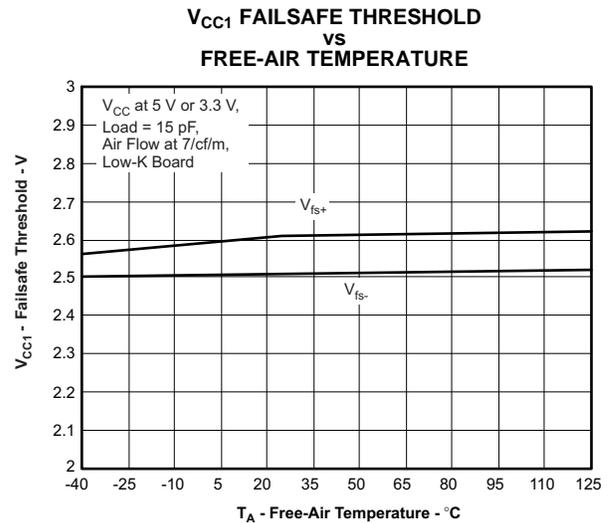


Figure 6.

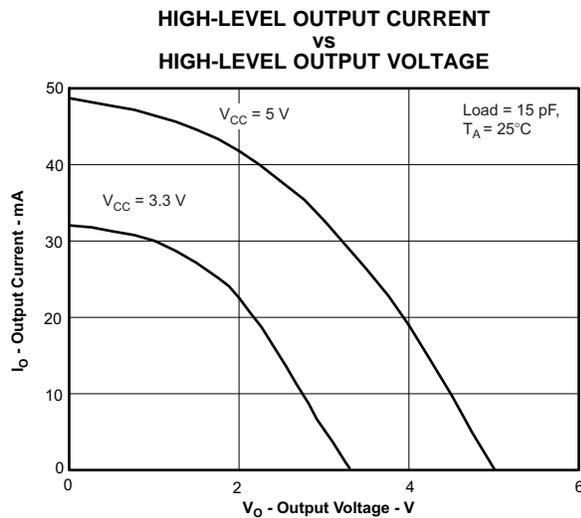


Figure 7.

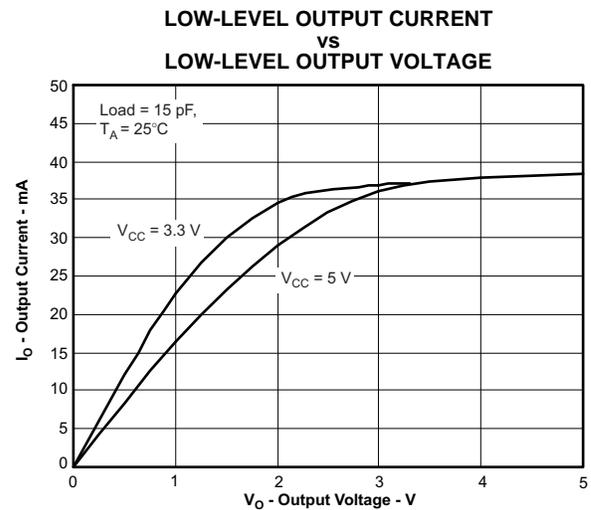


Figure 8.

APPLICATION INFORMATION

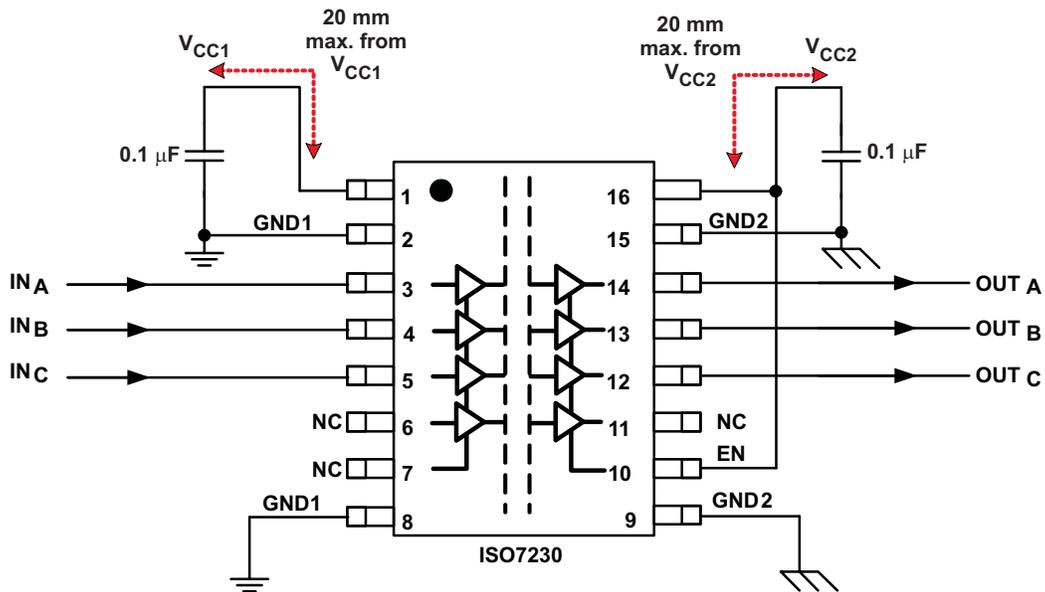


Figure 9. Typical ISO7230 Application Circuit

LIFE EXPECTANCY vs WORKING VOLTAGE

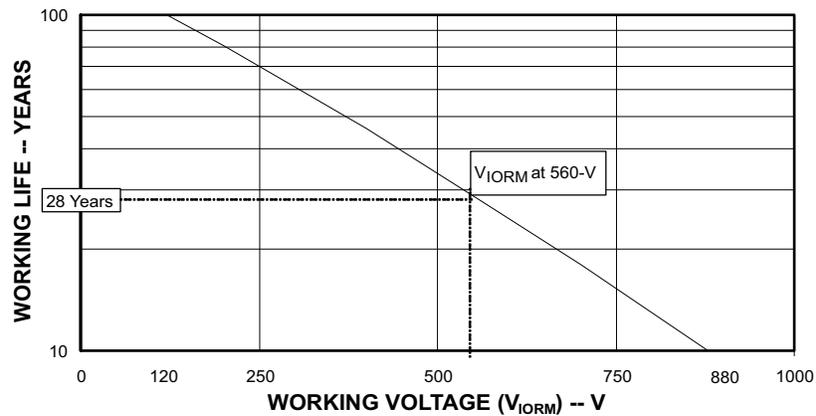


Figure 10. Time Dependant Dielectric Breakdown Testing Results

PRODUCT NOTIFICATION

An ISO723xA anomaly occurs when a negative-going pulse below the specified 1 μ s minimum bit width is input to the device. The output locks in a logic-low condition until the next rising edge occurs after a 1 μ s period.

Positive noise edges in pulses of less than the minimum specified 1 μ s have no effect on the device, and are properly filtered.

To prevent noise from interfering with ISO723xA performance, it is recommended that an appropriately sized capacitor be placed on each input of the device

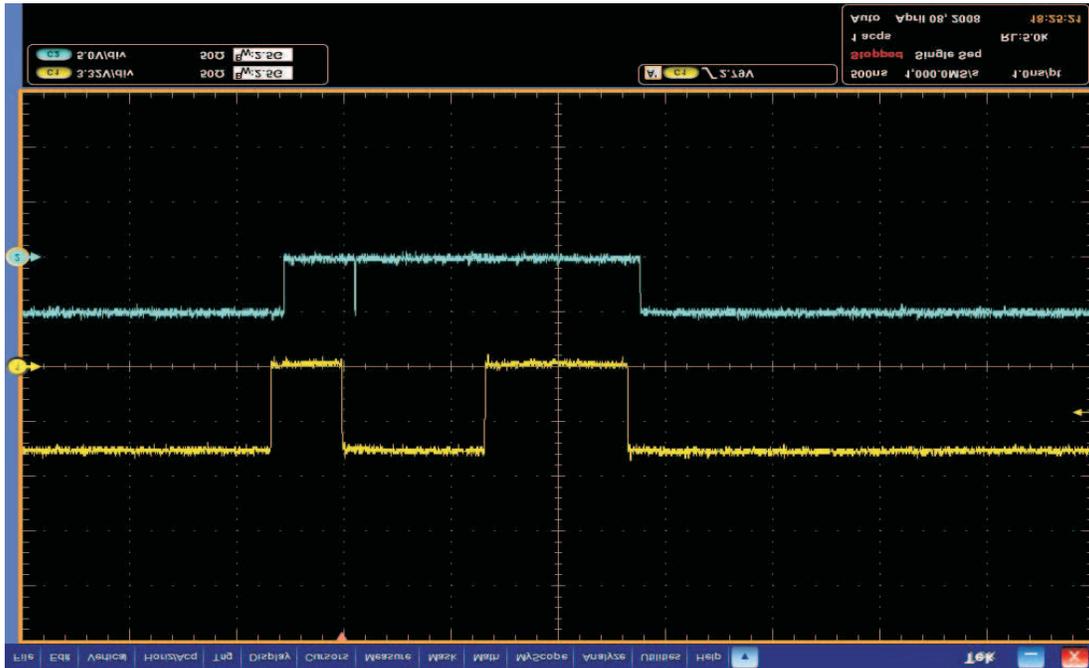
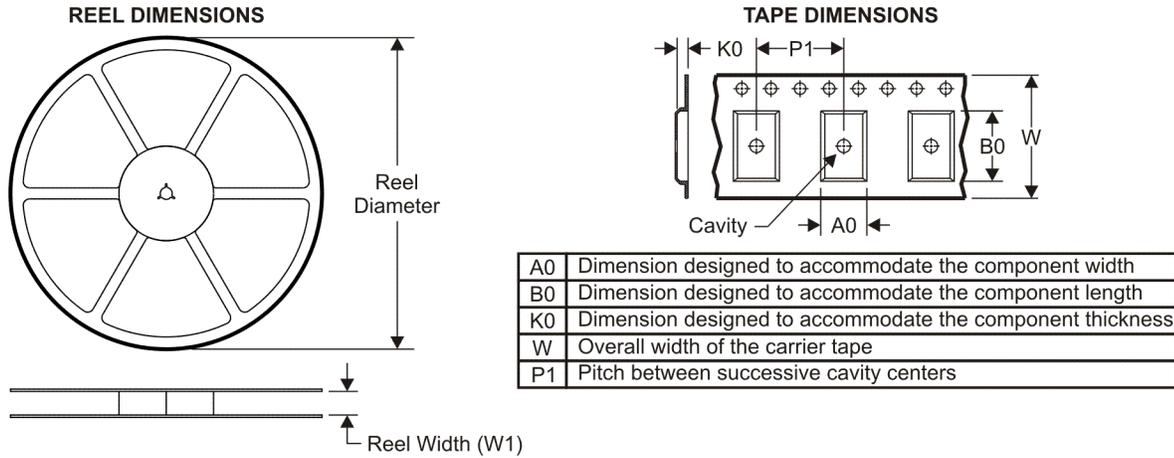
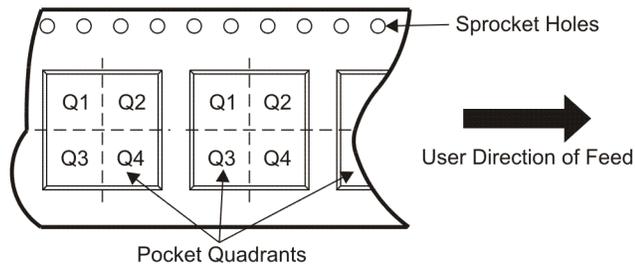


Figure 11. ISO723xA Anomaly

TAPE AND REEL INFORMATION



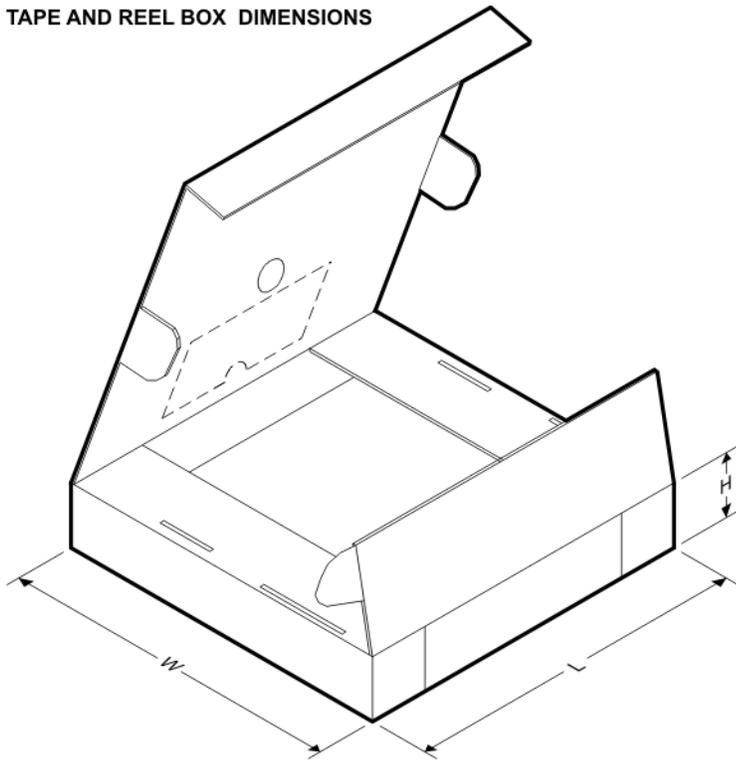
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ISO7230ADWR	SOIC	DW	16	2000	330.0	16.4	10.9	10.78	3.0	12.0	16.0	Q1
ISO7231ADWR	SOIC	DW	16	2000	330.0	16.4	10.9	10.78	3.0	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ISO7230ADWR	SOIC	DW	16	2000	358.0	335.0	35.0
ISO7231ADWR	SOIC	DW	16	2000	358.0	335.0	35.0

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